Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination 10/520,310 VAN DER MARK ET AL. Examiner Art Unit Page 1 of 1 HENOK G. HEYI 2627

U.S. PATENT DOCUMENTS

	U.S. I AILEN DOCUMENTO						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
*	Α	US-5,311,500 A	05-1994	Higuchi et al.	369/288		
*	В	US-6,055,222 A	04-2000	Knight, Gordon R.	369/13.13		
*	С	US-6,069,853 A	05-2000	Novotny et al.	369/13.33		
*	D	US-6,058,094 A	05-2000	Davis et al.	369/13.13		
*	Е	US-6,130,864 A	10-2000	Burroughs, Alan C.	369/13.13		
*	F	US-6,507,540 B1	01-2003	Berg et al.	369/13.13		
	G	US-					
	Н	US-					
	1	US-					
	J	US-					
	К	US-					
	٦	US-					
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FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS									
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	Q								
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	Т								

NON DATENT DOCUMENTS

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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